

September 2006 For Immediate Release

PTI to Showcase New Micro Leak Tester for Vials and Ampoules at Pack Expo in Chicago, IL

Tuckahoe, NY (September 22, 2006) – Packaging Technologies & Inspection (PTI) will introduce the new VeriPac Model 325/VA micro leak tester at the Pack Expo Show running October 29 – November 2, McCormick Place in Chicago IL, PTI Booth S-1878.

This new micro leak test system evaluates and analyzes the integrity of vials, ampoules and other rigid pharmaceutical containers with precision and repeatability. Test components are optimized for high sensitivity applications and high resolution requirements. Testing is non-destructive and produces results that are superior to traditional leak test methods.

Mike Kneller, R & D manager of PTI, states "The VeriPac 325/VA detects micro leaks in filled and sealed vials and ampoules, and is a practical alternative to the helium leak test." This inspection system utilizes an ASTM approved vacuum decay leak test method (F2338-05) recognized by the FDA as a consensus standard for package integrity testing. This test method was developed using VeriPac leak test instruments.

Kneller adds, "The 325/VA features an embedded flowmeter with automatic calibration. Leak rate, leak size results are available in various units of measurement like cc/min, Pa m³/sec. Data storage is virtually unlimited via USB memory cards. Enhanced data collection options for network connections and remote troubleshooting are also available."

About PTI

Packaging Technologies & Inspection (PTI) is a leading manufacturer of non-destructive inspection technologies for the pharmaceutical, medical device, food and container industries. Recognized as a thought leader in new delivery systems for seal, package and container integrity testing, PTI has set the standard for inspection systems that provide repeatable, reliable results. Having a PTI inspection solution in place for QA/QC process control guarantees that your package is "fit for purpose" from manufacturing through distribution.

Please contact Sanjeet Saxena for further information.